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December 2011

FDMQ8203

GreenBridge[™] Series of High-Efficiency Bridge Rectifiers Dual N-Channel and Dual P-Channel PowerTrench[®] MOSFET N-Channel: 100 V, 6 A, 110 mΩ P-Channel: -80 V, -6 A, 190 mΩ

Features

Q1/Q4: N-Channel

- Max $r_{DS(on)}$ = 110 m Ω at V_{GS} = 10 V, I_D = 3 A
- Max $r_{DS(on)}$ = 175 m Ω at V_{GS} = 6 V, I_D = 2.4 A

Q2/Q3: P-Channel

- Max $r_{DS(on)}$ = 190 m Ω at V_{GS} = -10 V, I_D = -2.3 A
- Max $r_{DS(on)}$ = 235 m Ω at V_{GS} = -4.5 V, I_D = -2.1 A
- Substantial efficiency benefit in PD solutions
- RoHS Compliant

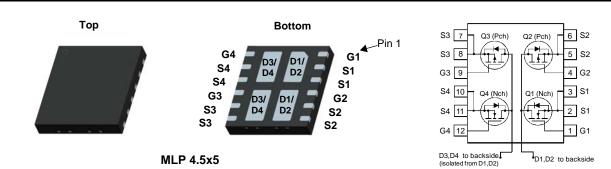


General Description

This quad mosfet solution provides ten-fold improvement in power dissipation over diode bridge.

Application

High-Efficiency Bridge Rectifiers



MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter	Parameter			Q2/Q3	Units
V _{DS}	Drain to Source Voltage	Drain to Source Voltage				V
V _{GS}	Gate to Source Voltage			±20	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		6	-6	
	-Continuous (Silicon limited)	T _C = 25 °C		10	-10	^
D	-Continuous	T _A = 25 °C	(Note 1a)	3.4	-2.6	A
	-Pulsed			12	-10	
D	Power Dissipation for Single Operation	T _C = 25 °C		22	37	w
P _D	Power Dissipation for Dual Operation $T_A = 25 \text{ °C}$ (Note 1a)		2	.5	vv	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to	+150	°C

Thermal Characteristics

R _{0JA}	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1b)	160	0/10

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMQ8203	FDMQ8203	MLP4.5x5	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = -250 \ \mu A, \ V_{GS} = 0 \ V$	Q1/Q4 Q2/Q3	100 -80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = -250 \ \mu$ A, referenced to 25 °C	Q1/Q4 Q2/Q3		72 -79		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80 V, V_{GS} = 0 V$ $V_{DS} = -64 V, V_{GS} = 0 V$	Q1/Q4 Q2/Q3			1 -1	μΑ μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Q1/Q4 Q2/Q3			±100 ±100	nA nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = -250 \ \mu A$	Q1/Q4 Q2/Q3	2 -1	3 -1.6	4 -3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = -250 \ \mu$ A, referenced to 25 °C	Q1/Q4 Q2/Q3		-8 5		mV/°C
	Drain to Course On Depintor	$V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$ $V_{GS} = 6 \text{ V}, I_D = 2.4 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, T_J = 125 \text{ °C}$	Q1/Q4		85 118 147	110 175 191	
r _{DS(on)}	Drain to Source On Resistance	$V_{GS} = -10 \text{ V}, I_D = -2.3 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -2.1 \text{ A}$ $V_{GS} = -10 \text{ V}, I_D = -2.3 \text{ A}, T_J = 125 \text{ °C}$	Q2/Q3		161 188 273	190 235 323	mΩ
	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$	Q1/Q4		6		s

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1/Q4: V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHZ	Q1/Q4 Q2/Q3	158 639	210 850	pF
C _{oss}	Output Capacitance	Q2/Q3:	Q1/Q4 Q2/Q3	41 46	55 65	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = -40 V, V _{GS} = 0 V, f = 1 MHZ	Q1/Q4 Q2/Q3	2.6 24	5 40	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	Q1/Q4:	Q1/Q4 Q2/Q3	3.8 4.7	10 10	ns
t _r	Rise Time	$V_{\text{DD}} = 50 \text{ V}, \text{ I}_{\text{D}} = 3 \text{ A},$ $V_{\text{GS}} = 10 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$	Q1/Q4 Q2/Q3	1.3 2.8	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2/Q3:	Q1/Q4 Q2/Q3	7.5 22	15 35	ns
t _f	Fall Time	V_{DD} = -40 V, I _D = -2.3 A, V _{GS} = -10 V, R _{GEN} = 6 Ω	Q1/Q4 Q2/Q3	1.9 2.7	10 10	ns
Qg	Total Gate Charge	VGS = 0 V to 10 V VGS = 0 V to -10 V Q1/Q4:	Q1/Q4 Q2/Q3	2.9 13	5 19	nC
Qg	Total Gate Charge	$ \begin{array}{c} VGS = 0 \ V \ to \ 5 \ V \\ VGS = 0 \ V \ to \ -4.5 \ V \\ \end{array} \begin{array}{c} V_{DD} = 50 \ V, \\ I_{D} = 3 \ A \end{array} $	Q1/Q4 Q2/Q3	1.6 6.4	3 10	nC
Q _{gs}	Gate to Source Gate Charge	Q2/Q3: V _{DD} = -40 V,	Q1/Q4 Q2/Q3	0.8 1.6		nC
Q _{gd}	Gate to Drain "Miller" Charge	$I_{\rm D} = -2.3 {\rm A}$	Q1/Q4 Q2/Q3	0.8 2.6		nC

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-So	urce Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage				0.86 -0.82	1.3 -1.3	V
t _{rr}	Reverse Recovery Time	Q1/Q4: I _F = 3 A, di/dt = 100 A/μs	Q1/Q4 Q2/Q3		32 26	52 42	ns
Q _{rr}	Reverse Recovery Charge	Q2/Q3: I _F = -2.3 A, di/dt = 100 A/μs	Q1/Q4 Q2/Q3		21 26	34 42	nC

Notes:

1: $R_{0,LA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{0,LC}$ is guaranteed by design while R_{0CA} is determined by the user's board design.

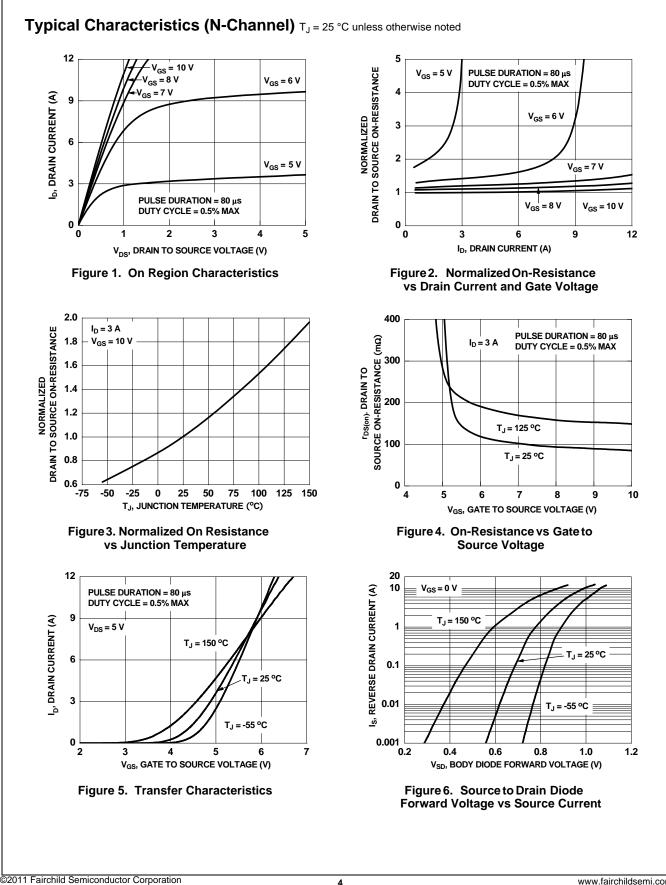


a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4.



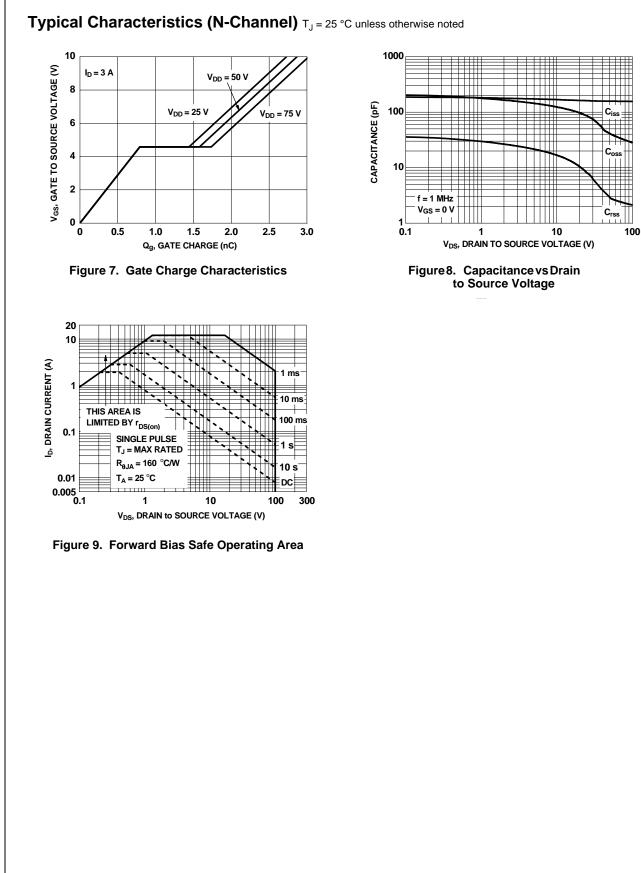
b. 160 °C/W when mounted on a minimum pad of 2 oz copper, the board designed Q1+Q3 or Q2+Q4.

2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

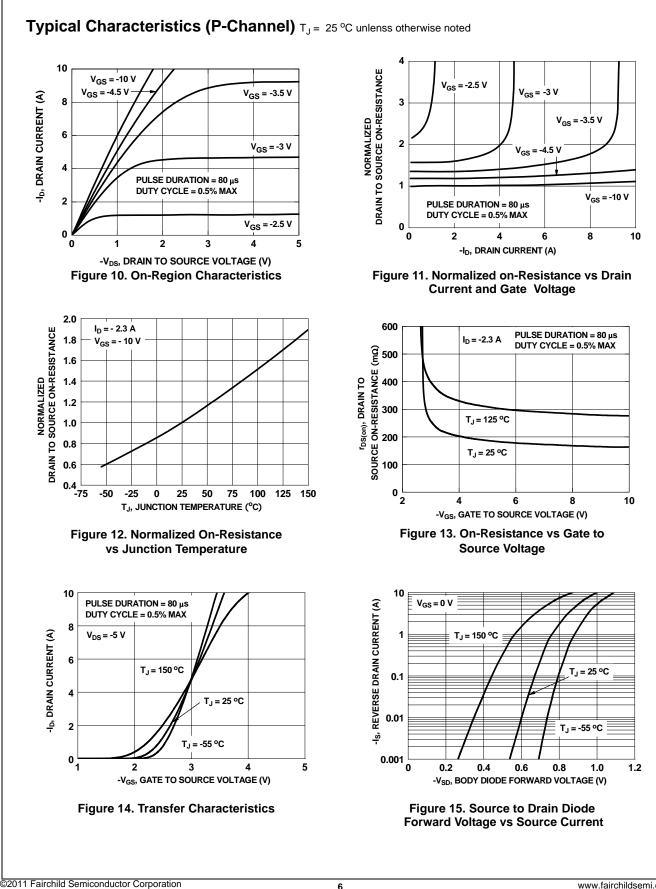


FDMQ8203 Rev.C1

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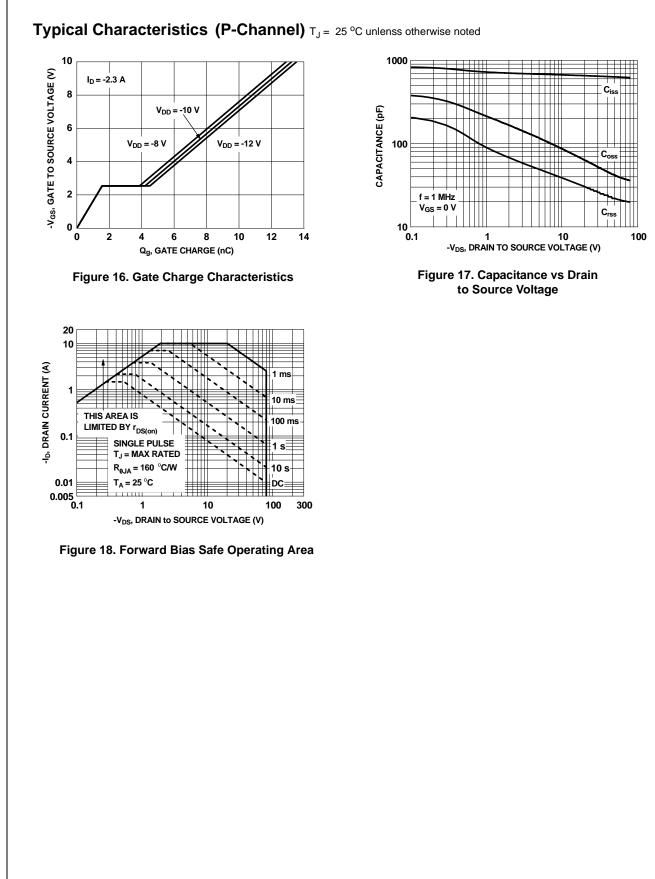




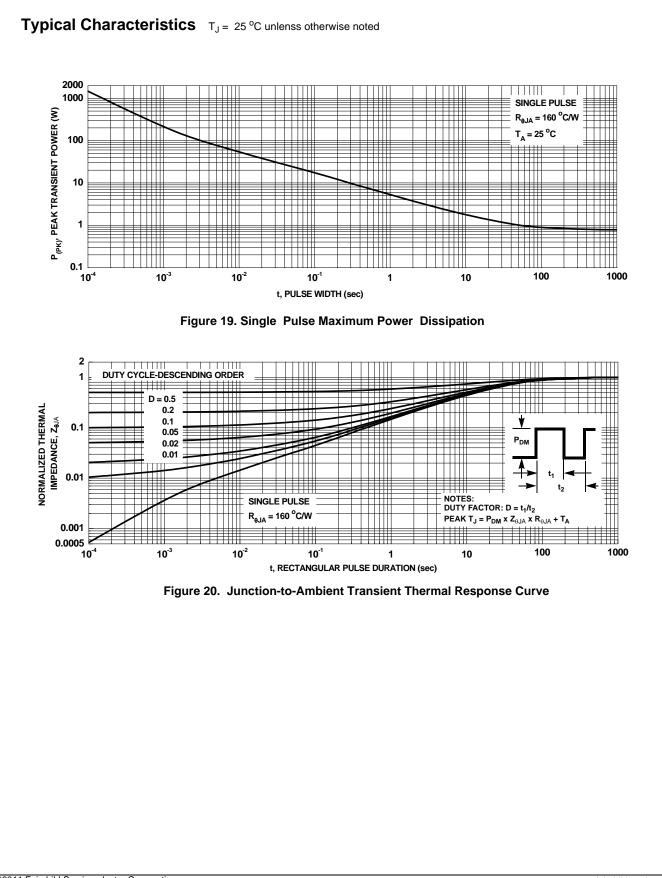


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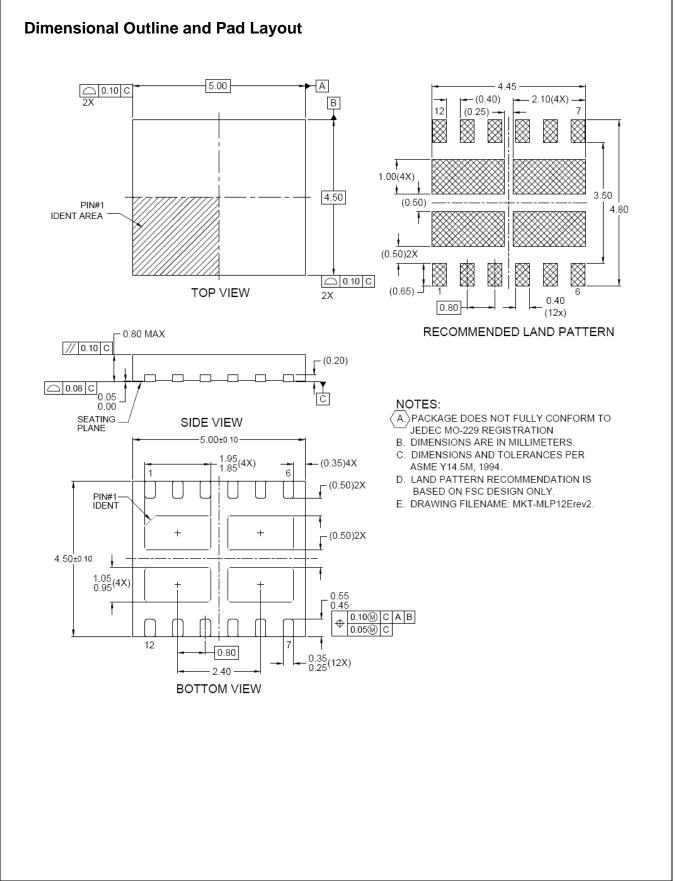
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